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(12) **United States Design Patent**  
**Oonuma et al.**

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(54) **ELECTRON MICROSCOPE**

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(\*\*) Term: **14 Years**

(21) Appl. No.: **29/339,397**

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(30) **Foreign Application Priority Data**

Mar. 19, 2009 (JP) ..... 2009-006242

(51) **LOC (9) Cl.** ..... **16-06**

(52) **U.S. Cl.** ..... **D16/131**

(58) **Field of Classification Search** ..... D16/130, D16/131, 221, 234; D24/186, 232, 216; D10/81; D13/184; 250/311; 359/383, 384, 359/385, 389, 390, 368, 370, 371, 372, 363  
See application file for complete search history.

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(57) **CLAIM**

We claim the ornamental design for an electron microscope, as shown and described.

**DESCRIPTION**

FIG. 1 is a front, top and right side perspective view of electron microscope showing our new design;

FIG. 2 is a front elevational view thereof;

FIG. 3 is a rear elevational view thereof;

FIG. 4 is a left side elevational view thereof;

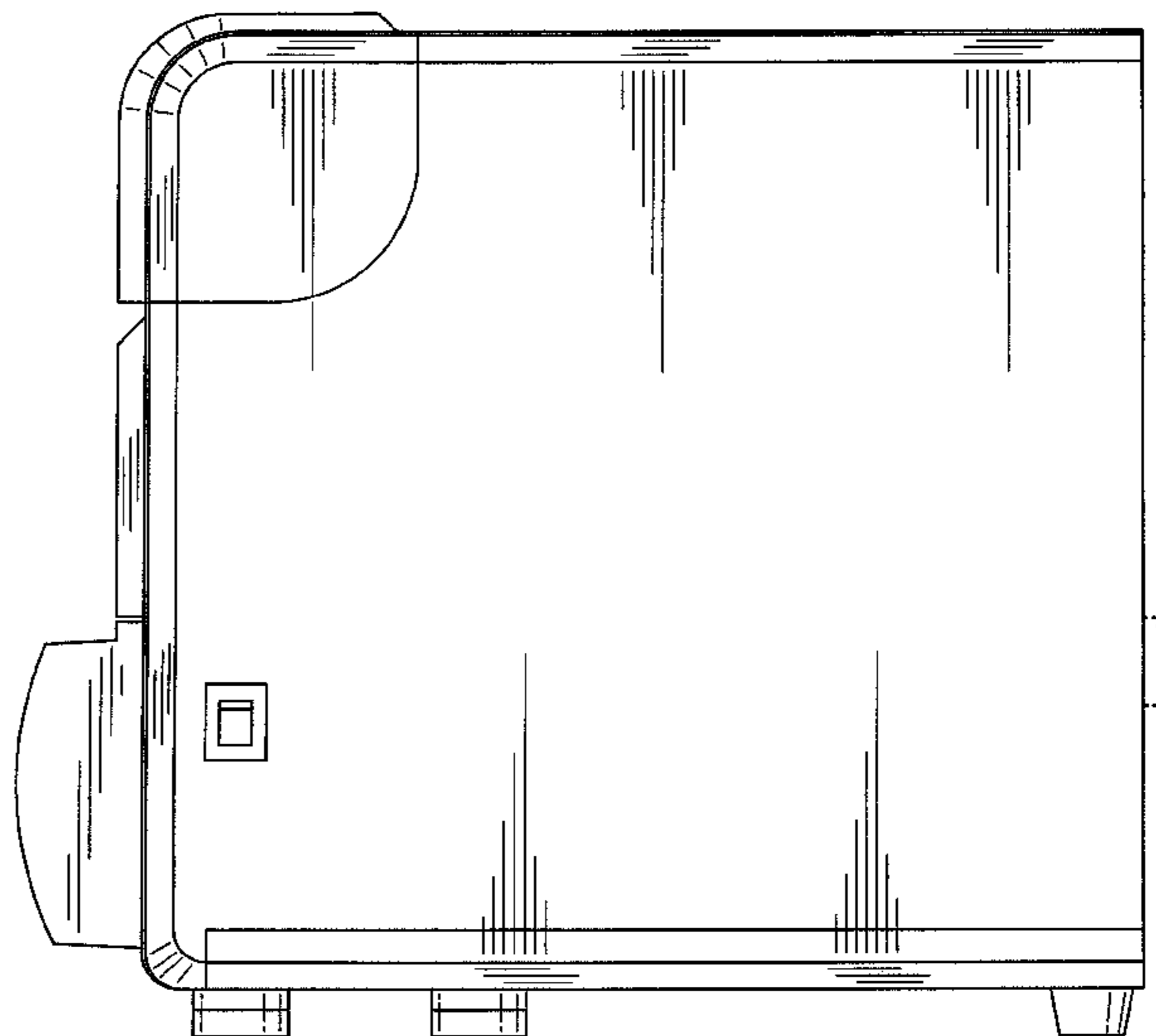
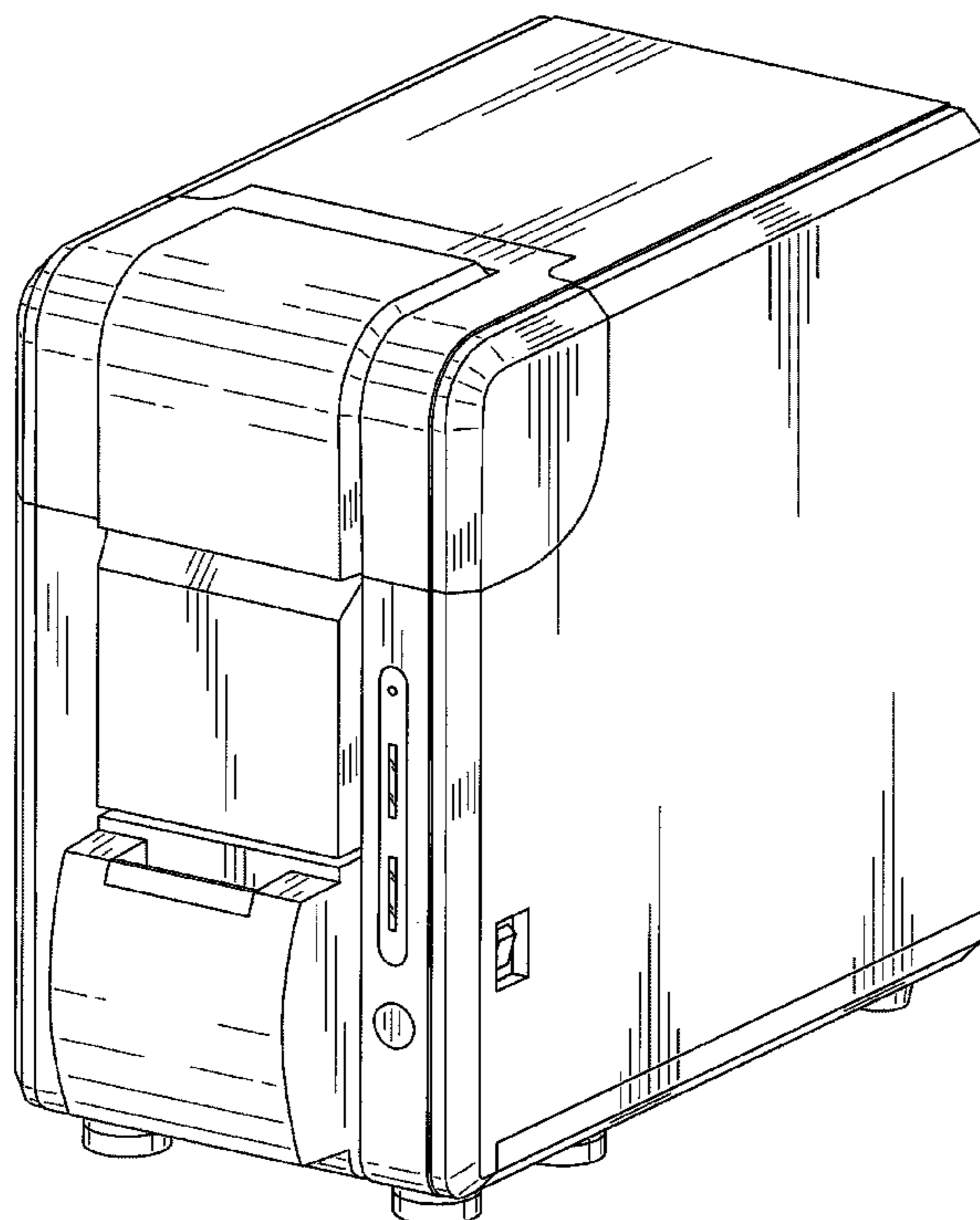
FIG. 5 is a right side elevational view thereof;

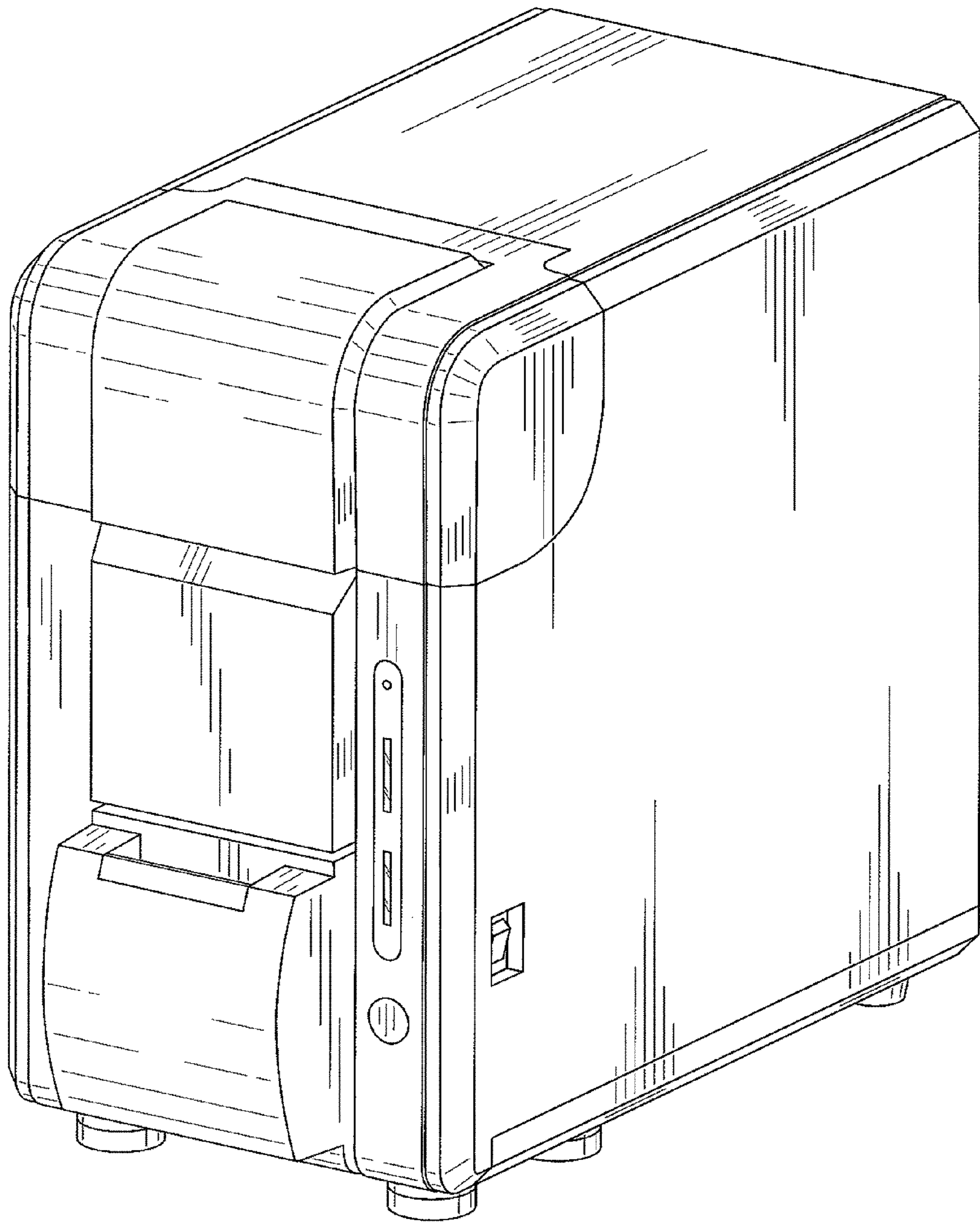
FIG. 6 is a top plan view thereof; and,

FIG. 7 is a bottom plan view thereof.

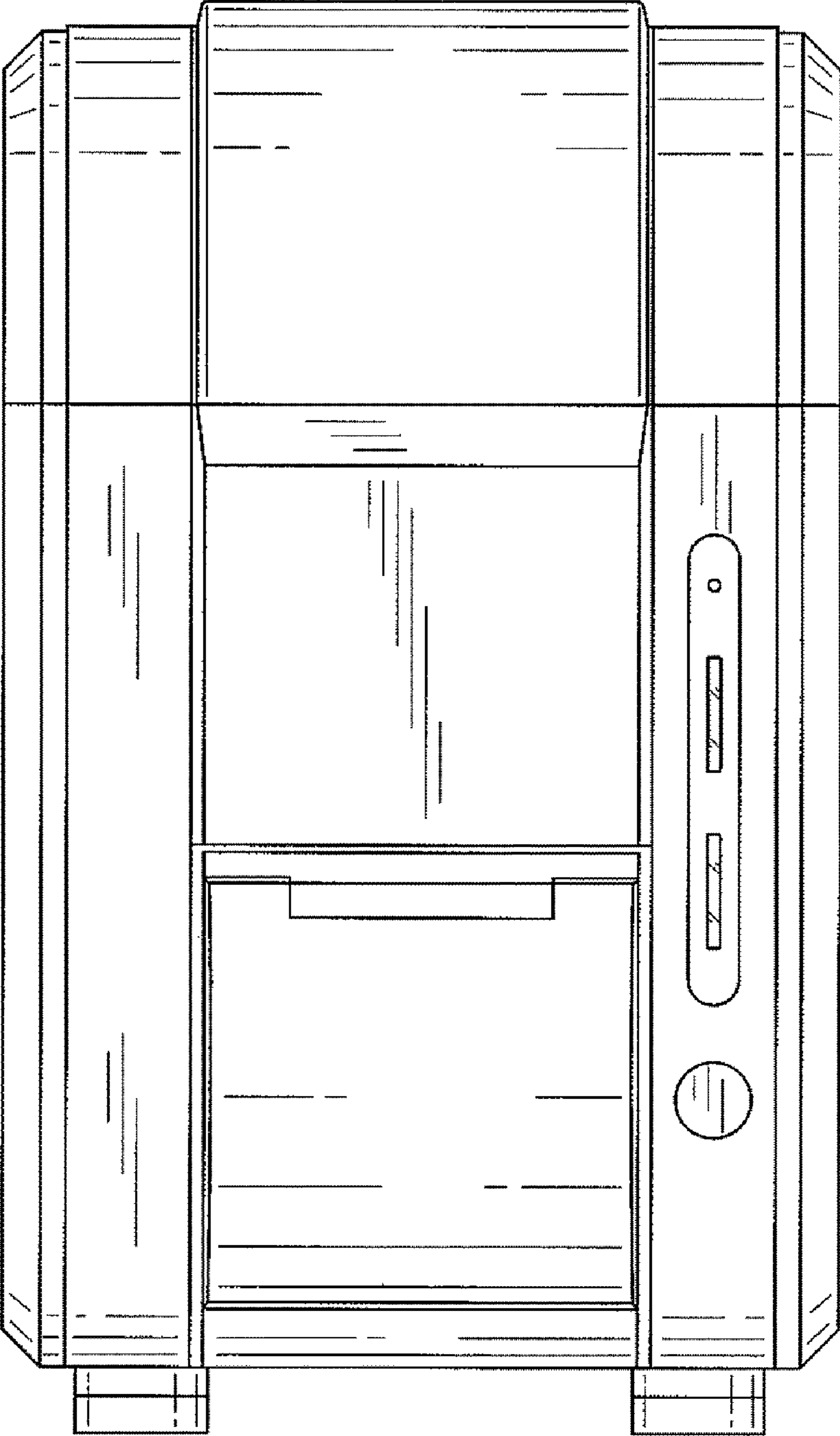
The broken lines form no part of the claimed design.

**1 Claim, 7 Drawing Sheets**

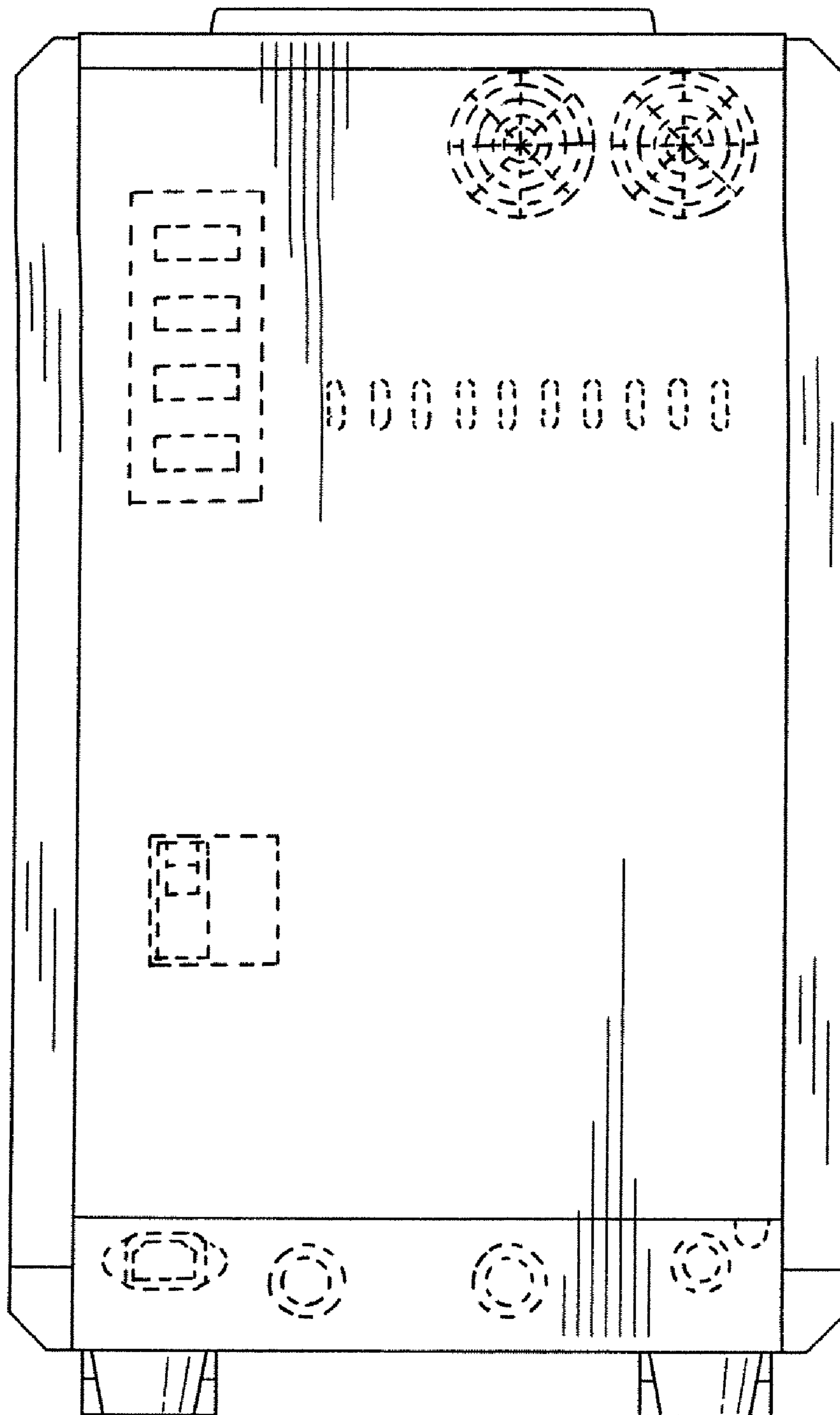




**FIG. 1**



*FIG. 2*



**FIG. 3**

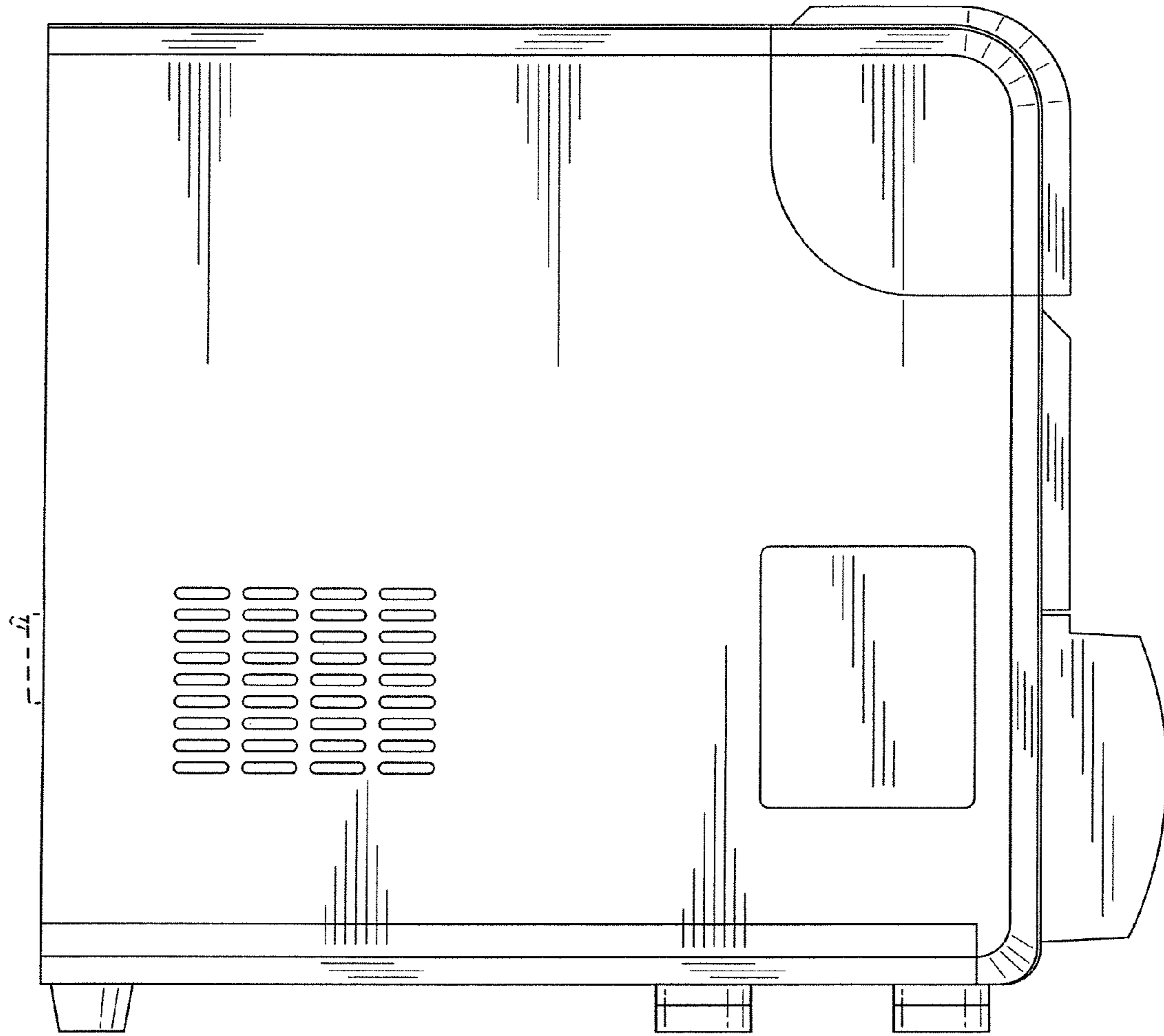


FIG. 4

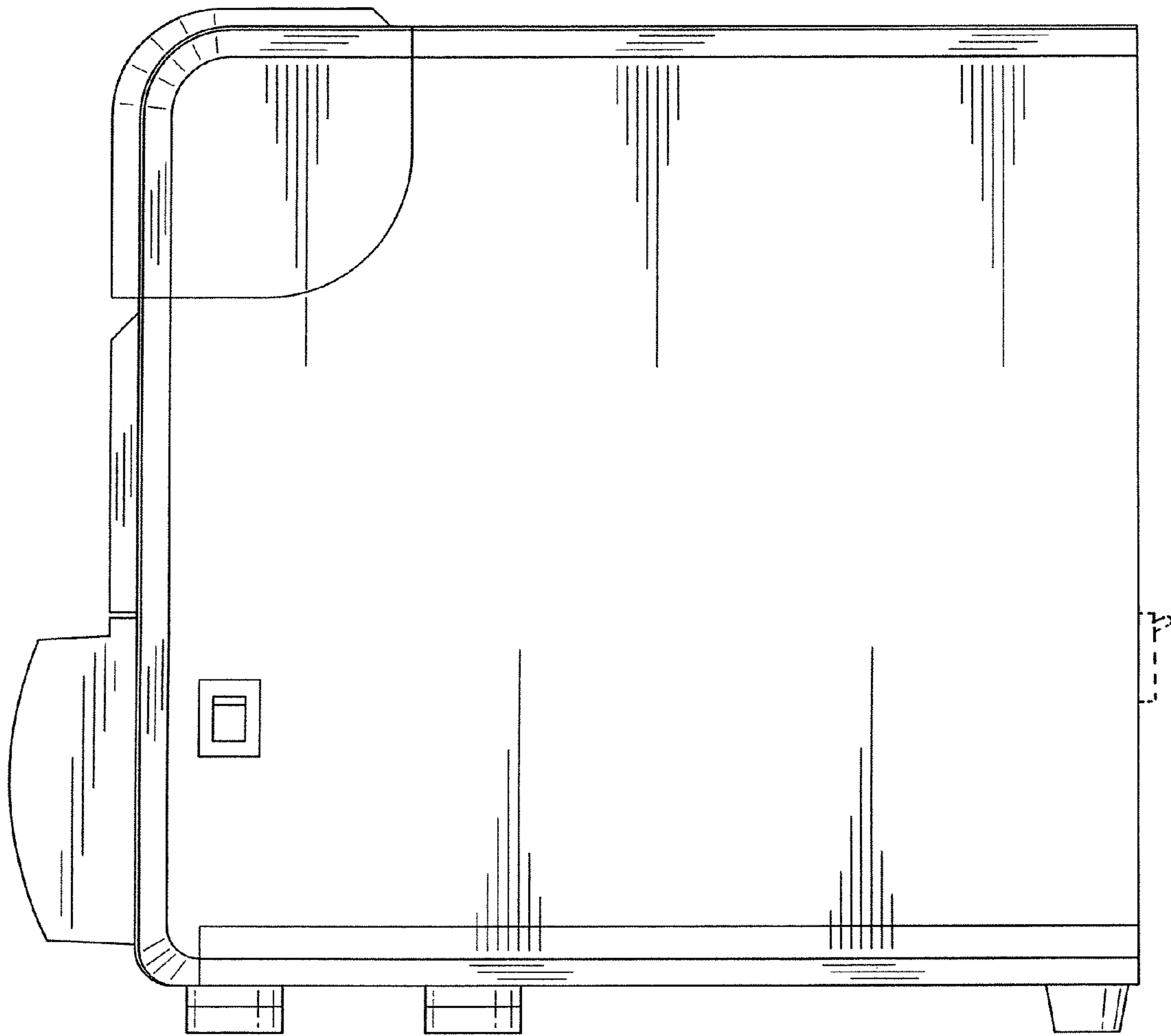
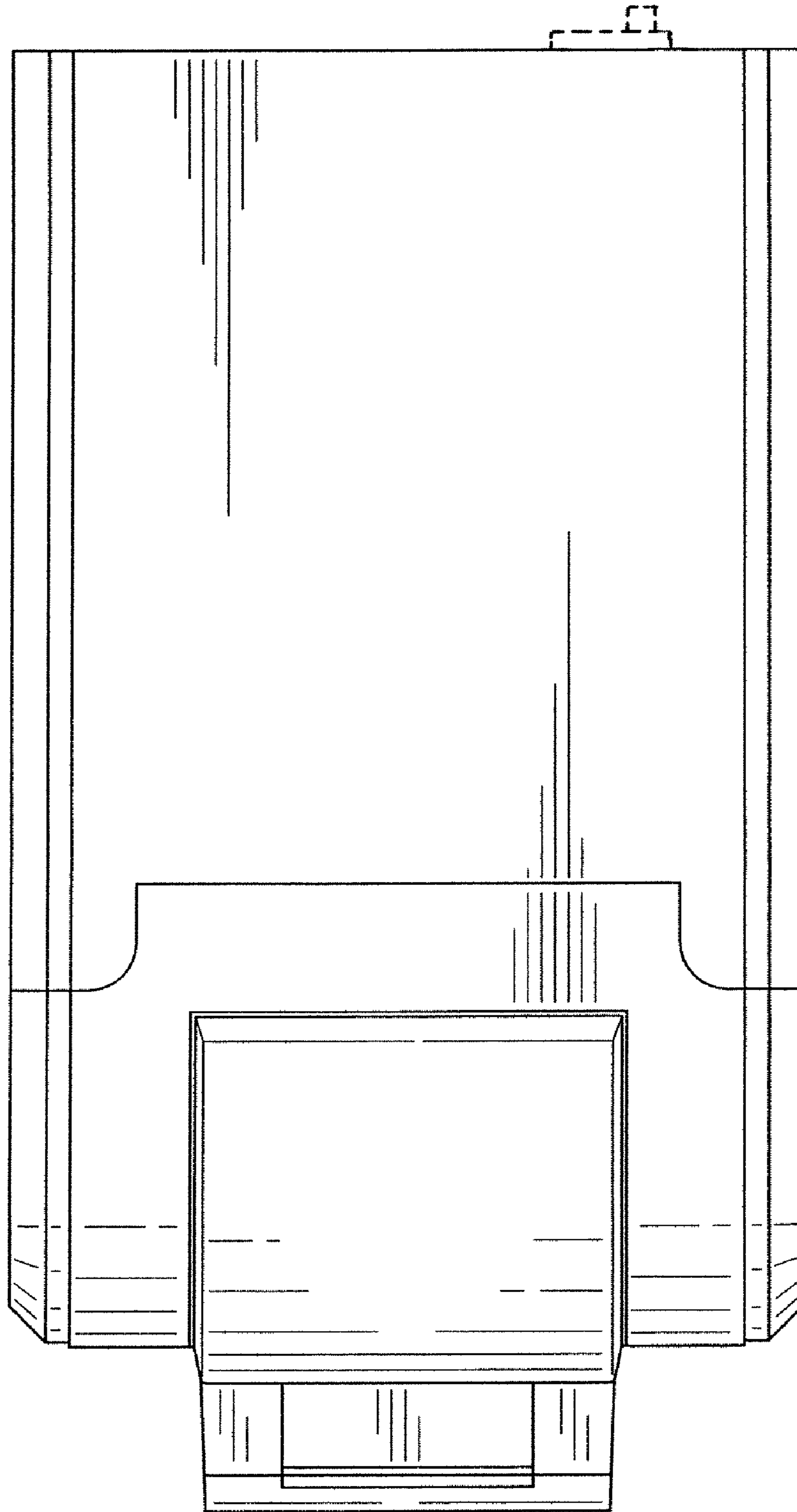
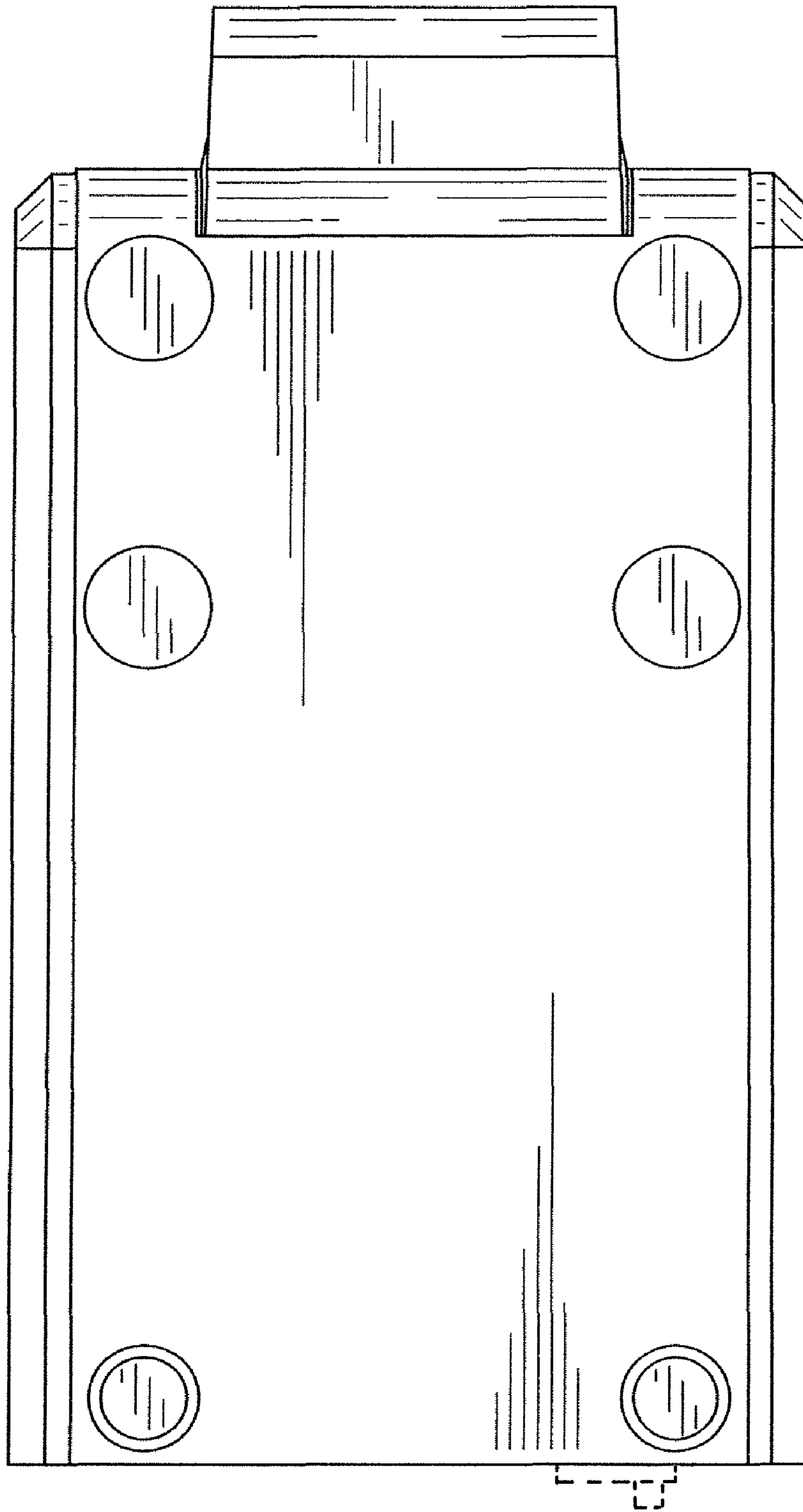


FIG. 5



*FIG. 6*



*FIG. 7*